Unit: mm

TOSHIBA Transistor Silicon PNP · NPN Epitaxial Type (PCT Process) (Bias Resistor Built-in Transistor)

RN4905FE

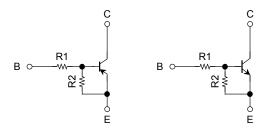
Switching, Inverter Circuit, Interface Circuit and Driver Circuit Applications

- Two devices are incorporated into an Extreme-Super-Mini (6-pin) package.
- Incorporating a bias resistor into a transistor reduces parts count.
 Reducing the parts count enables the manufacture of ever more compact equipment and lowers assembly cost.

Equivalent Circuit and Bias Resistor Values

Q2

Q1



R1: 2.2 $k\Omega$

R2: 47 $k\Omega$

(Q1, Q2 common)

1.6±0.05 1.2±0.05

1. EMITTER1 (E1) & 2. BASE1 (B1) & 3. COLLECTOR2 (C2) & 4. EMITTER2 (E2) & 5. BASE2 (B2) & 6. COLLECTOR1 (C1)

ES6

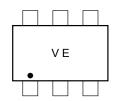
JEDEC —
JEITA —

2-2N1G

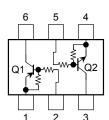
Weight: 0.003g (typ.)

TOSHIBA

Marking



Equivalent Circuit (top view)





Maximum Ratings (Ta = 25°C) (Q1)

Characteristics	Symbol	Rating	Unit
Collector-base voltage	V_{CBO}	-50	V
Collector-emitter voltage	V _{CEO}	-50	V
Emitter-base voltage	V _{EBO}	-5	V
Collector current	I _C	-100	mA

Maximum Ratings (Ta = 25°C) (Q2)

Characteristics	Symbol	Rating	Unit
Collector-base voltage	V_{CBO}	50	V
Collector-emitter voltage	V _{CEO}	50	V
Emitter-base voltage	V _{EBO}	5	٧
Collector current	IC	100	mA

Maximum Ratings (Ta = 25°C) (Q1, Q2 common)

Characteristics	Symbol	Rating	Unit
Collector power dissipation	P _C (Note)	100	mW
Junction temperature	Tj	150	°C
Storage temperature range	T _{stg}	-55~150	°C

Note: Total rating



Electrical Characteristics (Ta = 25°C) (Q1)

Characteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Collector cut-off current	I _{CBO}	$V_{CB} = -50 \text{ V}, I_E = 0$	_	_	-100	nA
	I _{CEO}	$V_{CE} = -50 \text{ V}, I_B = 0$	_	_	-500	ш
Emitter cut-off current	I _{EBO}	$V_{EB} = -5 \text{ V}, I_C = 0$	-0.078	_	-0.145	mA
DC current gain	h _{FE}	$V_{CE} = -5 \text{ V}, I_{C} = -10 \text{ mA}$	80	_	_	
Collector-emitter saturation voltage	V _{CE (sat)}	$I_C = -5 \text{ mA}, I_B = -0.25 \text{ mA}$		-0.1	-0.3	V
Input voltage (ON)	V _{I (ON)}	$V_{CE} = -0.2 \text{ V}, I_{C} = -5 \text{ mA}$	-0.6	_	-1.1	V
Input voltage (OFF)	V _{I (OFF)}	$V_{CE} = -5 \text{ V}, I_{C} = -0.1 \text{ mA}$	-0.5	_	-0.8	٧
Transition frequency	f _T	$V_{CE} = -10 \text{ V}, I_{C} = -5 \text{ mA}$	_	200	_	MHz
Collector output capacitance	C _{ob}	$V_{CB} = -10 \text{ V}, I_E = 0, f = 1 \text{ MHz}$	_	3	6	pF

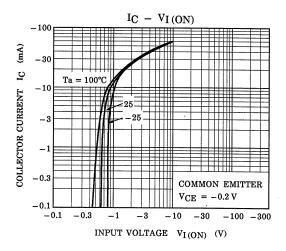
Electrical Characteristics (Ta = 25°C) (Q2)

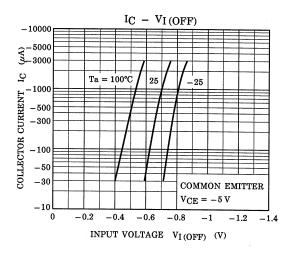
Characteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Collector cut-off current	I _{CBO}	$V_{CB} = 50 \text{ V}, I_{E} = 0$	_	_	100	nA
	ICEO	$V_{CE} = 50 \text{ V}, I_{B} = 0$	_	_	500	IIA
Emitter cut-off current	I _{EBO}	$V_{EB} = 5 V, I_{C} = 0$	0.078	_	0.145	mA
DC current gain	h _{FE}	$V_{CE} = 5 \text{ V}, I_{C} = 10 \text{ mA}$	80	_	_	
Collector-emitter saturation voltage	V _{CE (sat)}	$I_C = 5 \text{ mA}, I_B = 0.25 \text{ mA}$	_	0.1	0.3	V
Input voltage (ON)	V _{I (ON)}	$V_{CE} = 0.2 \text{ V}, I_{C} = 5 \text{ mA}$	0.6	_	1.1	V
Input voltage (OFF)	V _{I (OFF)}	$V_{CE} = 5 \text{ V}, I_{C} = 0.1 \text{ mA}$	0.5	_	0.8	V
Transition frequency	f _T	$V_{CE} = 10 \text{ V}, I_{C} = 5 \text{ mA}$	_	250	_	MHz
Collector output capacitance	C _{ob}	V _{CB} = 10 V, I _E = 0, f = 1 MHz	_	3	6	pF

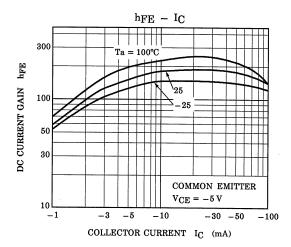
Electrical Characteristics (Ta = 25°C) (Q1, Q2 common)

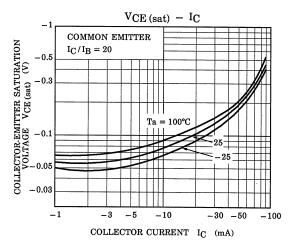
Characteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Input resistor	R1	_	1.54	2.2	2.86	kΩ
Resistor ratio	R1/R2	_	0.0421	0.0468	0.0515	

Q1



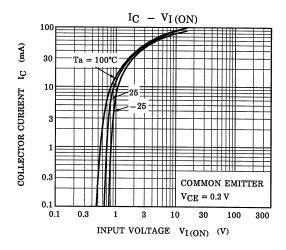


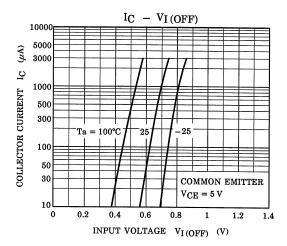


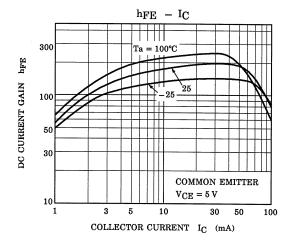


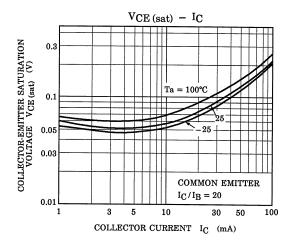
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Q2









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